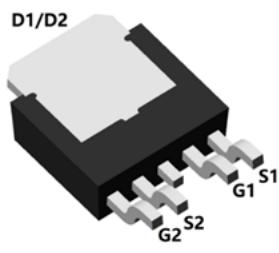
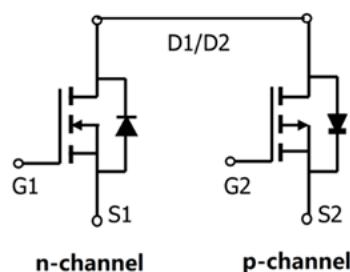


N-Channel and P-Channel Complementary MOSFET


TO-252-4L


Product Summary

NMOS

- V_{DS} 30V
- I_D 50A
- $R_{DS(ON)}$ (at $V_{GS}=10V$) $<8.1m\Omega$
- $R_{DS(ON)}$ (at $V_{GS}=4.5V$) $<12.6m\Omega$

PMOS

- V_{DS} -30V
- I_D -30A
- $R_{DS(ON)}$ (at $V_{GS}=-10V$) $<18m\Omega$
- $R_{DS(ON)}$ (at $V_{GS}=-4.5V$) $<28m\Omega$
- 100% EAS Tested
- 100% ∇V_{DS} Tested

General Description

- Excellent package for heat dissipation
- High density cell design for low $R_{DS(ON)}$
- Moisture Sensitivity Level 1
- Epoxy Meets UL 94 V-0 Flammability Rating
- Halogen Free

Applications

- Load switching
- Hard switched and high frequency circuits
- Uninterruptible power supply

■ Absolute Maximum Ratings ($T_J=25^\circ C$ unless otherwise noted)

Parameter				Symbol	NMOS	PMOS	Unit	
Drain-source Voltage				V_{DS}	30	-30	V	
Gate-source Voltage				V_{GS}	± 20	± 20	V	
Continuous Drain Current (Note 1,2)	Steady-State	$T_A=25^\circ C$	NMOS: $V_{GS}=10V$	I_D	13.7	-9.4	A	
			PMOS: $V_{GS}=-10V$		8.6	-5.9		
	Steady-State	$T_A=100^\circ C$	NMOS: $V_{GS}=10V$		50	-30		
			PMOS: $V_{GS}=-10V$		31.6	-19		
Pulsed Drain Current	$T_c=25^\circ C$, $t_p=100\mu s$			I_{DM}	200	-120	A	
Avalanche energy	NMOS: $V_G=10V$, $R_G=25\Omega$, $L=0.5mH$, $I_{AS}=10.5A$			EAS	27.5	30.2	mJ	
	PMOS: $V_G=-10V$, $R_G=25\Omega$, $L=0.5mH$, $I_{AS}=-11A$							
Total Power Dissipation (Note 1,2)	Steady-State	$T_A=25^\circ C$		P_D	2.5	2.5	W	
		$T_A=100^\circ C$			1	1		
Total Power Dissipation (Note 1,3)	Steady-State	$T_c=25^\circ C$			35.7	29.7		
		$T_c=100^\circ C$			14.2	11.9		
Junction and Storage Temperature Range				T_J, T_{STG}	-55~+150	-55~+150	°C	



YJD35NP03B

■ Thermal resistance

Parameter	Symbol	NMOS		PMOS		Units
		Typ	Max	Typ	Max	
Thermal Resistance Junction-to-Ambient (Note 2)	R _{θJA}	40	50	40	50	°C/W
Thermal Resistance Junction-to-Case	R _{θJC}	2.9	3.5	3.5	4.2	

■ Ordering Information (Example)

PREFERRED P/N	PACKING CODE	Marking	MINIMUM PACKAGE(pcs)	INNER BOX QUANTITY(pcs)	OUTER CARTON QUANTITY(pcs)	DELIVERY MODE
YJD35NP03B	F1/F2	YJD35NP03B	2500	/	25000	13"Reel

■ NMOS Electrical Characteristics (T_J=25°C unless otherwise noted)

Parameter	Symbol	Conditions	Min	Typ	Max	Units
Static Parameter						
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} = 0V, I _D =250μA	30	-	-	V
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} =30V, V _{GS} =0V	-	-	1	μA
		V _{DS} =30V, V _{GS} =0V, T _J =150°C	-	-	100	
Gate-Body Leakage Current	I _{GSS}	V _{GS} = ±20V, V _{DS} =0V	-	-	±100	nA
Gate Threshold Voltage	V _{GS(th)}	V _{DS} = V _{GS} , I _D =250μA	1	1.5	2.5	V
Static Drain-Source On-Resistance	R _{DS(on)}	V _{GS} =10V, I _D =20A	-	6.2	8.1	mΩ
		V _{GS} =4.5V, I _D =20A	-	9.3	12.6	
Diode Forward Voltage	V _{SD}	I _S =20A, V _{GS} =0V	-	-	1.2	V
Gate resistance	R _G	f=1MHz	-	2.5	-	Ω
Maximum Body-Diode Continuous Current	I _S		-	-	50	A
Dynamic Parameters						
Input Capacitance	C _{iss}	V _{DS} =15V, V _{GS} =0V, f=1MHz	-	1016	-	pF
Output Capacitance	C _{oss}		-	176	-	
Reverse Transfer Capacitance	C _{rss}		-	150	-	
Switching Parameters						
Total Gate Charge	Q _g	V _{GS} =10V, V _{DS} =15V, I _D =20A	-	24	-	nC
Gate-Source Charge	Q _{gs}		-	5	-	
Gate-Drain Charge	Q _{gd}		-	6	-	
Reverse Recovery Charge	Q _{rr}	I _f =20A, di/dt=100A/us	-	0.66	-	nC
Reverse Recovery Time	t _{rr}		-	10	-	ns
Turn-on Delay Time	t _{D(on)}	V _{GS} =10V, V _{DD} =15V, I _D =20A R _{GEN} =3Ω	-	11	-	ns
Turn-on Rise Time	t _r		-	55	-	
Turn-off Delay Time	t _{D(off)}		-	27	-	
Turn-off fall Time	t _f		-	66	-	



YJD35NP03B

■ PMOS Electrical Characteristics ($T_J=25^\circ\text{C}$ unless otherwise noted)

Parameter	Symbol	Conditions	Min	Typ	Max	Units
Static Parameter						
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{\text{GS}}=0\text{V}, I_{\text{D}}=-250\mu\text{A}$	-30	-	-	V
Zero Gate Voltage Drain Current	$I_{\text{DS}(\text{SS})}$	$V_{\text{DS}}=-30\text{V}, V_{\text{GS}}=0\text{V}$	-	-	-1	μA
		$V_{\text{DS}}=-30\text{V}, V_{\text{GS}}=0\text{V}, T_J=150^\circ\text{C}$	-	-	-100	
Gate-Body Leakage Current	I_{GSS}	$V_{\text{GS}}= \pm 20\text{V}, V_{\text{DS}}=0\text{V}$	-	-	± 100	nA
Gate Threshold Voltage	$V_{\text{GS}(\text{th})}$	$V_{\text{DS}}=V_{\text{GS}}, I_{\text{D}}=-250\mu\text{A}$	-1	-1.5	-2.5	V
Static Drain-Source On-Resistance	$R_{\text{DS}(\text{on})}$	$V_{\text{GS}}=-10\text{V}, I_{\text{D}}=-20\text{A}$	-	14	18	$\text{m}\Omega$
		$V_{\text{GS}}=-4.5\text{V}, I_{\text{D}}=-20\text{A}$	-	21	28	
Diode Forward Voltage	V_{SD}	$I_{\text{S}}=-20\text{A}, V_{\text{GS}}=0\text{V}$	-	-	-1.2	V
Gate resistance	R_{G}	$f=1\text{MHz}$	-	15	-	Ω
Maximum Body-Diode Continuous Current	I_{S}		-	-	-30	A
Dynamic Parameters						
Input Capacitance	C_{iss}	$V_{\text{DS}}=-15\text{V}, V_{\text{GS}}=0\text{V}, f=1\text{MHz}$	-	1210	-	pF
Output Capacitance	C_{oss}		-	180	-	
Reverse Transfer Capacitance	C_{rss}		-	150	-	
Switching Parameters						
Total Gate Charge	Q_{g}	$V_{\text{GS}}=-10\text{V}, V_{\text{DS}}=-15\text{V}, I_{\text{D}}=-10\text{A}$	-	24	-	nC
Gate-Source Charge	Q_{gs}		-	2	-	
Gate-Drain Charge	Q_{gd}		-	6	-	
Reverse Recovery Charge	Q_{rr}	$I_{\text{F}}=-10\text{A}, \text{di}/\text{dt}=100\text{A}/\text{us}$	-	11	-	nC
Reverse Recovery Time	t_{rr}		-	35	-	
Turn-on Delay Time	$t_{\text{D}(\text{on})}$	$V_{\text{GS}}=-10\text{V}, V_{\text{DD}}=-15\text{V}, I_{\text{D}}=-10\text{A}$ $R_{\text{GEN}}=2.5\Omega$	-	11	-	ns
Turn-on Rise Time	t_{r}		-	4	-	
Turn-off Delay Time	$t_{\text{D}(\text{off})}$		-	70	-	
Turn-off fall Time	t_{f}		-	50	-	

Note:

- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- The value of R_{QJA} is measured with the device mounted on the 40mm*40mm*1.1mm single layer FR-4 PCB board with 1 in² pad of 2oz. Copper, in the still air environment with $TA = 25^\circ\text{C}$. The maximum allowed junction temperature of 150°C . The value in any given application depends on the user's specific board design.
- Thermal resistance from junction to soldering point (on the exposed drain pad).



YJD35NP03B

■ NMOS Typical Electrical and Thermal Characteristics Diagrams

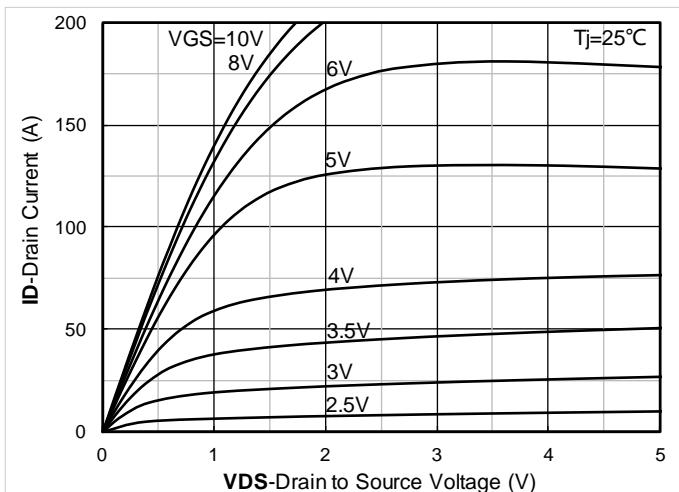


Figure 1. Output Characteristics

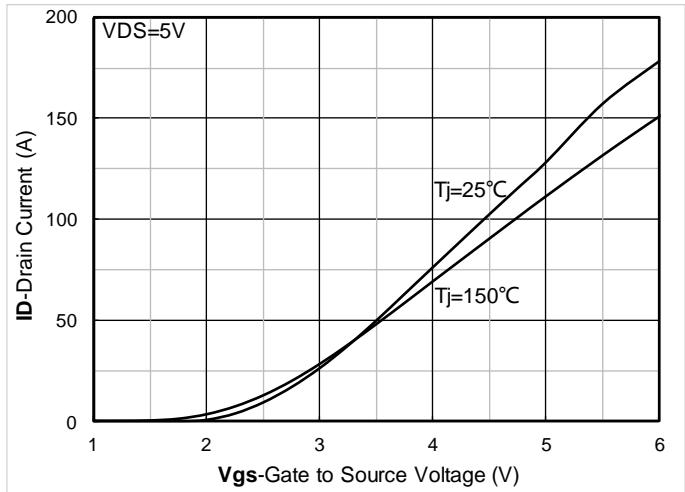


Figure 2. Transfer Characteristics

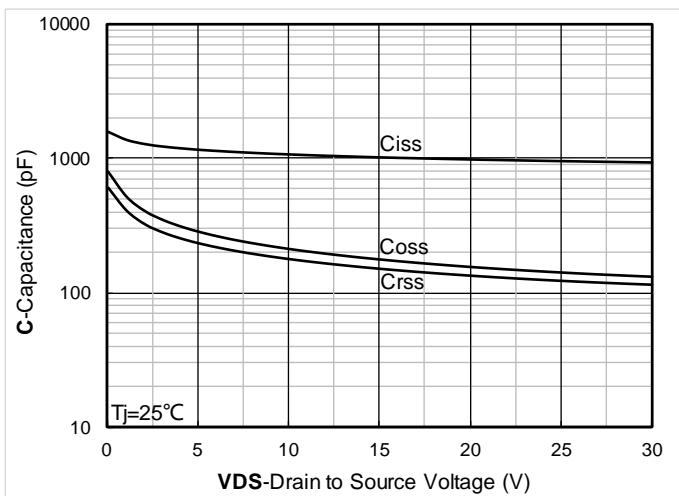


Figure 3. Capacitance Characteristics

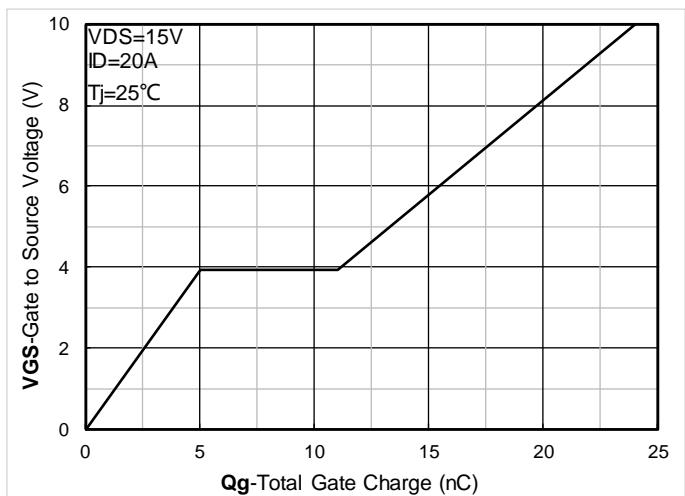


Figure 4. Gate Charge

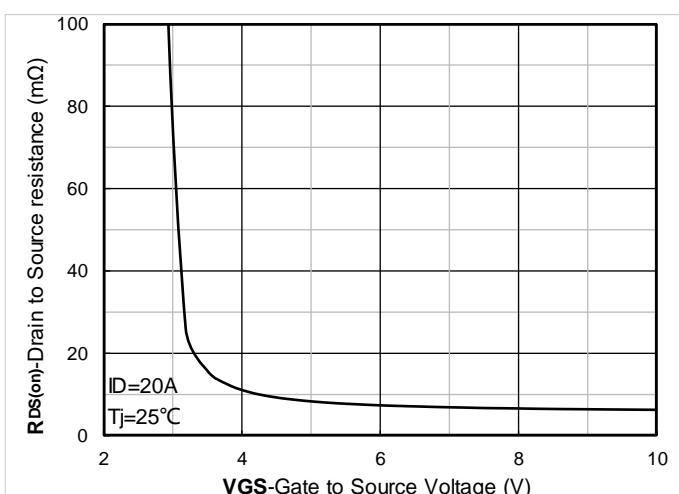


Figure 5. On-Resistance vs Gate to Source Voltage

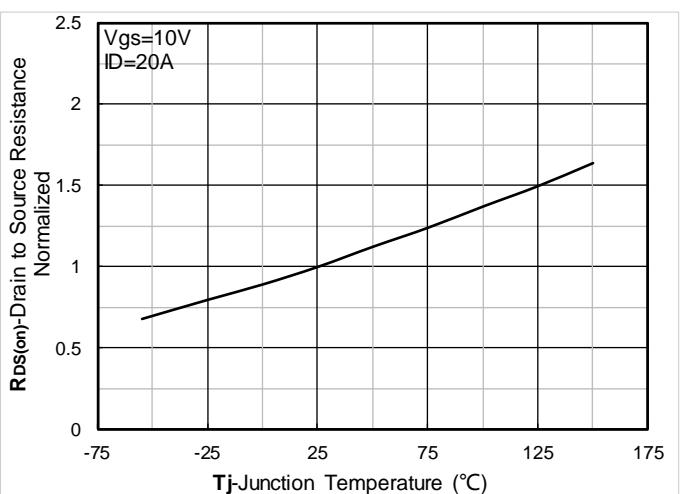


Figure 6. Normalized On-Resistance

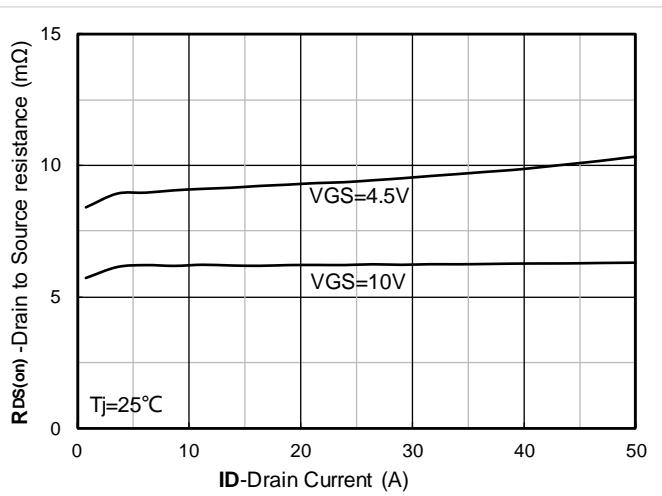


Figure 7. RDS(on) VS Drain Current

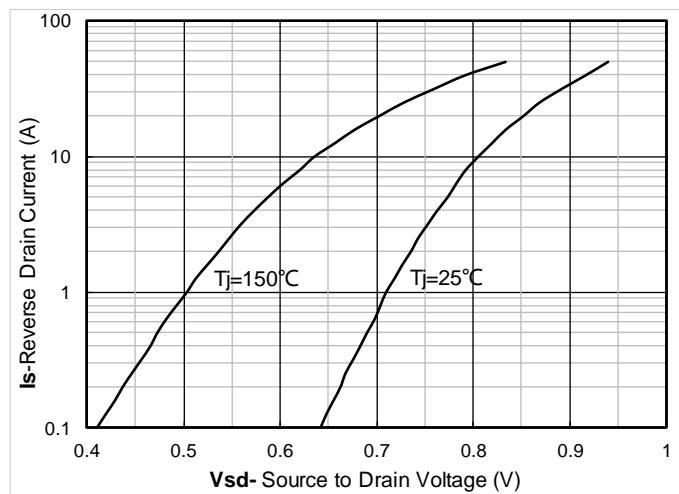


Figure 8. Forward characteristics of reverse diode

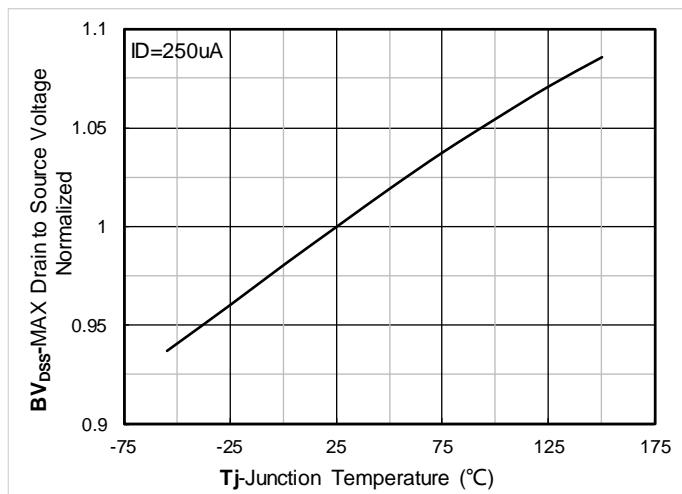


Figure 9. Normalized breakdown voltage

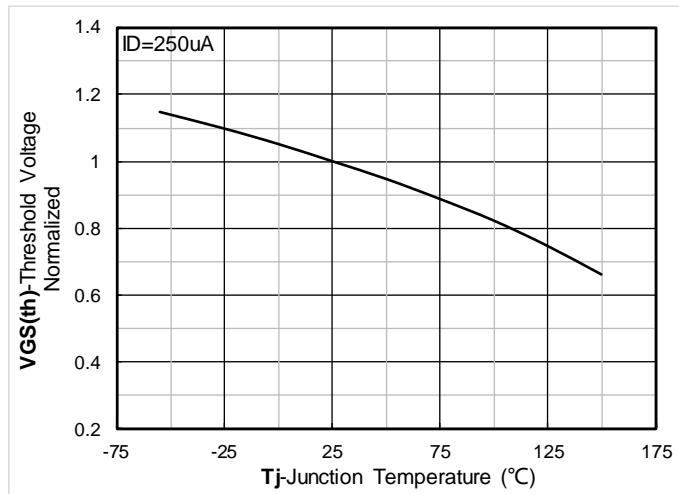


Figure 10. Normalized Threshold voltage

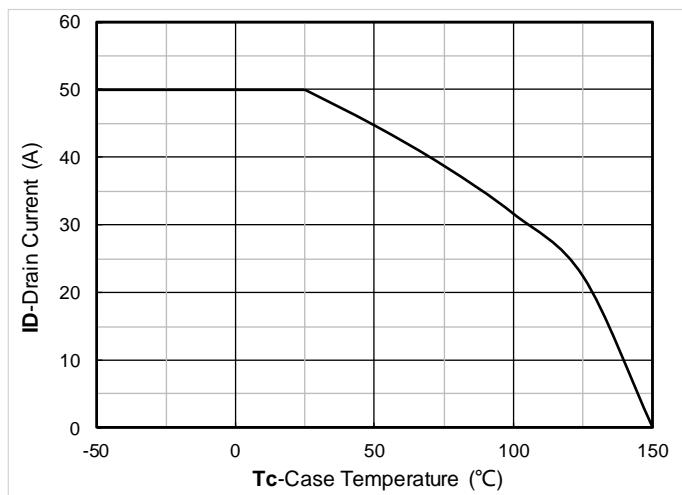


Figure 11. Current dissipation

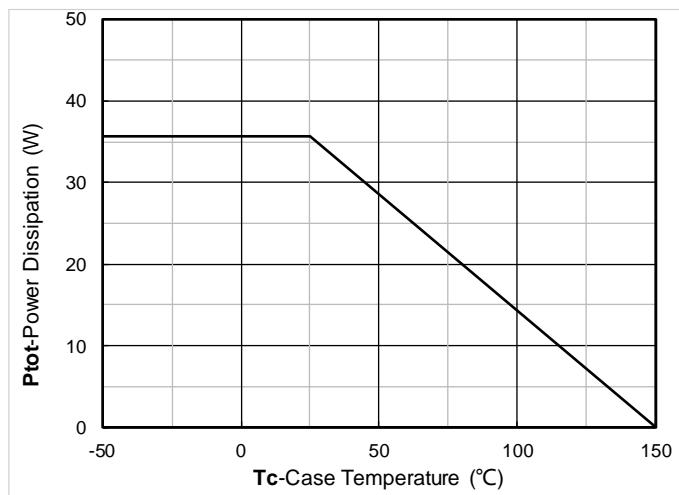


Figure 12. Power dissipation

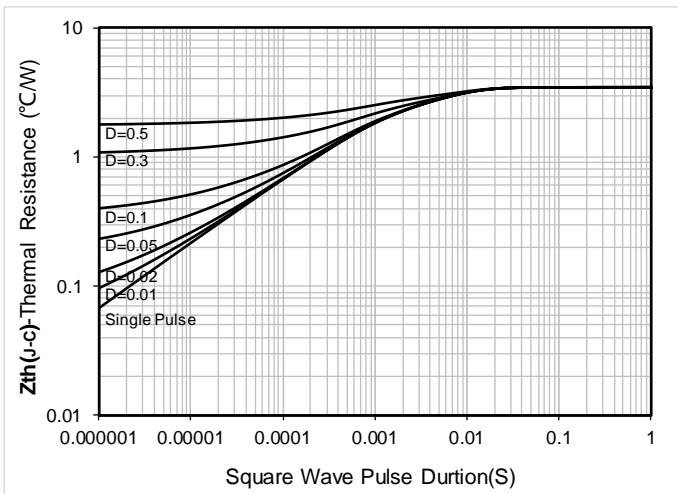


Figure 13. Maximum Transient Thermal Impedance

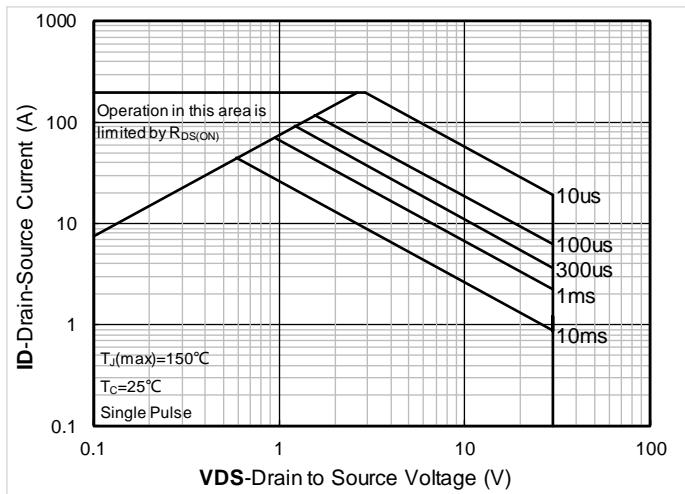


Figure 14. Safe Operation Area

■ PMOS Typical Electrical and Thermal Characteristics Diagrams

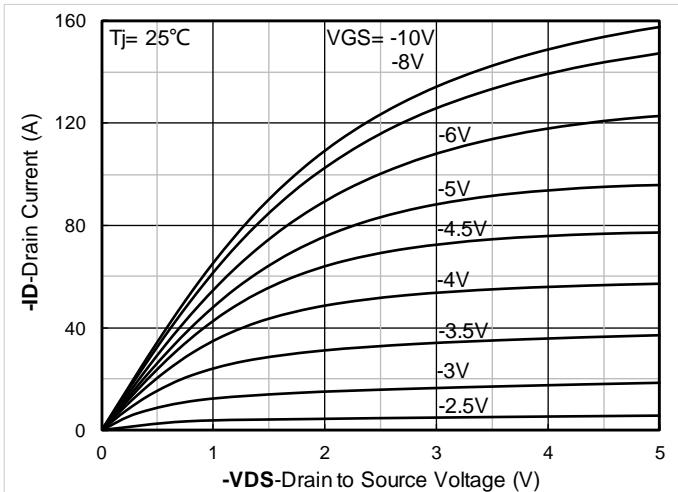


Figure 1. Output Characteristics

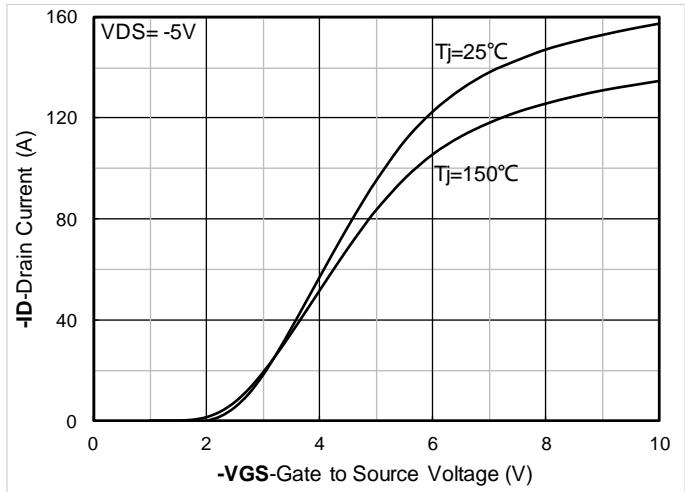


Figure 2. Transfer Characteristics

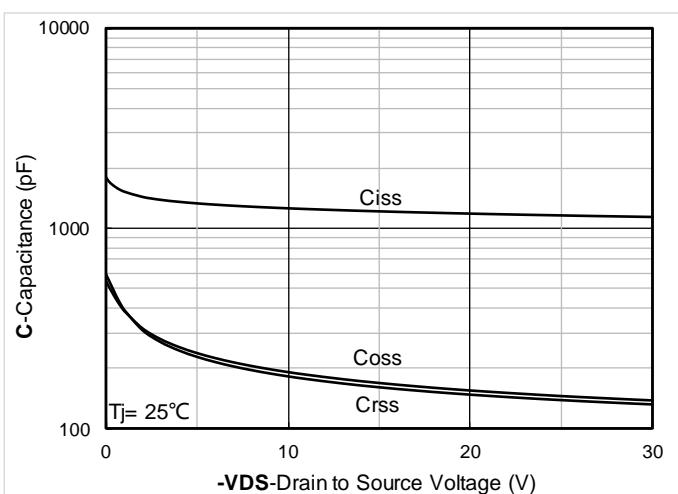


Figure 3. Capacitance Characteristics

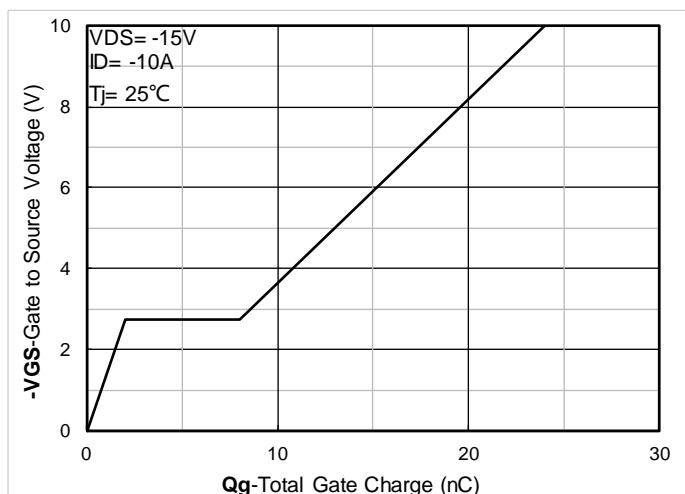


Figure 4. Gate Charge



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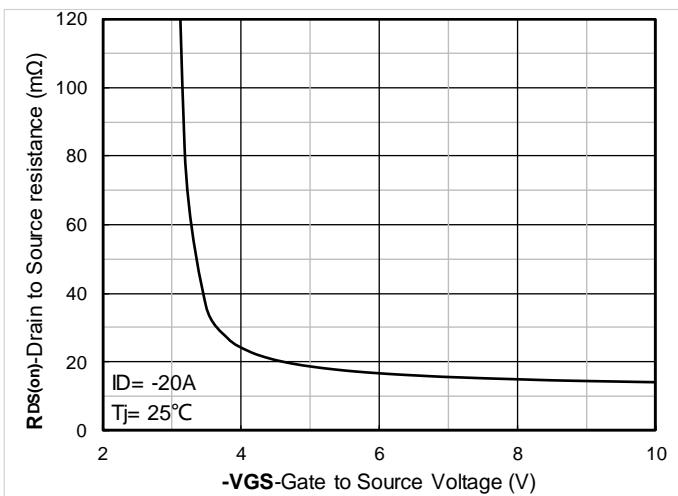


Figure 5. On-Resistance vs Gate to Source Voltage

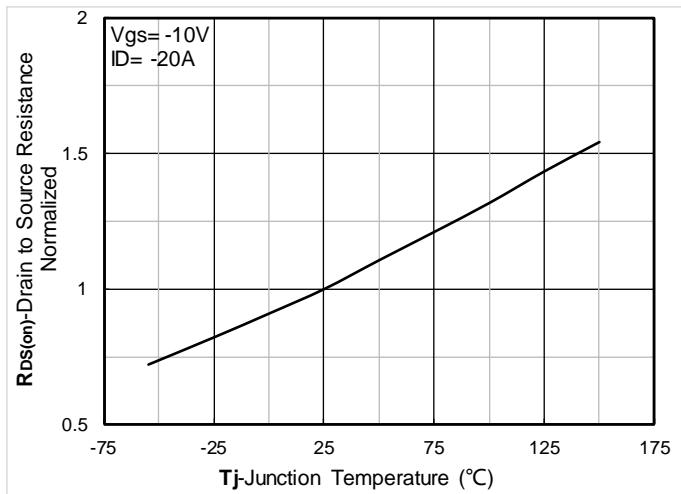


Figure 6. Normalized On-Resistance

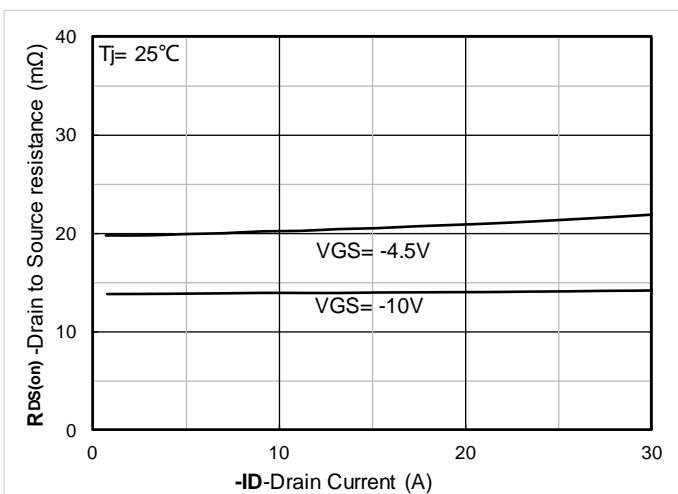


Figure 7. $R_{DS(on)}$ VS Drain Current

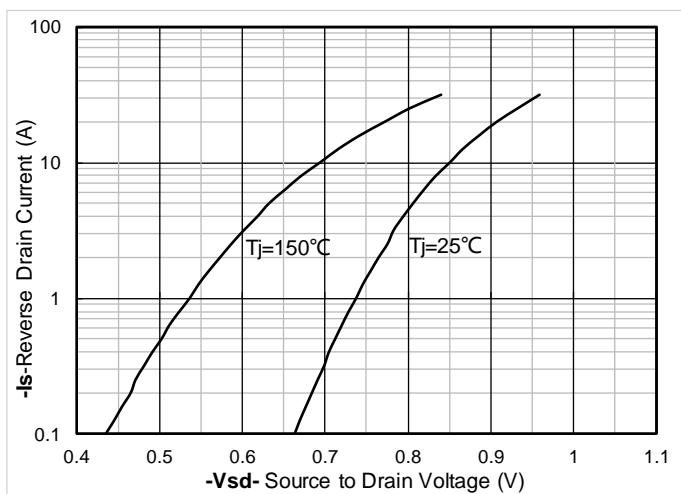


Figure 8. Forward characteristics of reverse diode

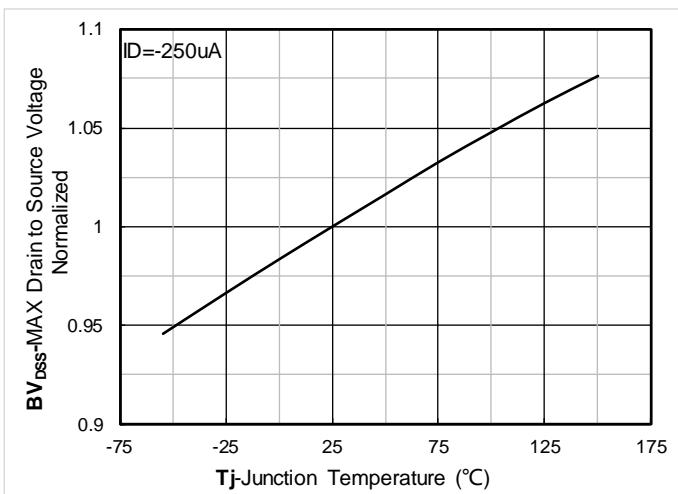


Figure 9. Normalized breakdown voltage

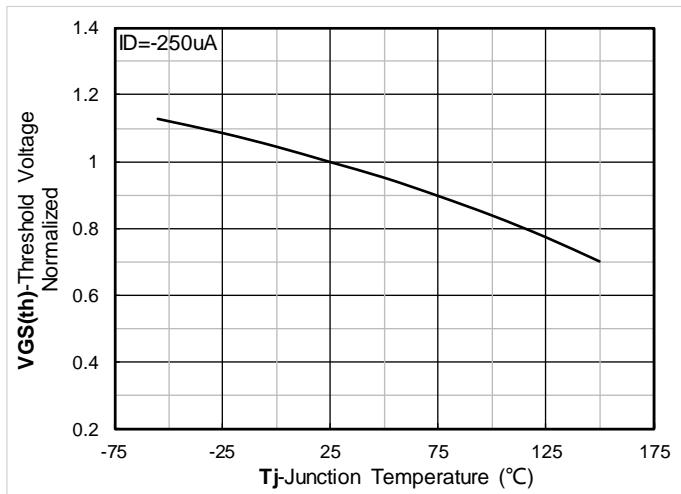


Figure 10. Normalized Threshold voltage



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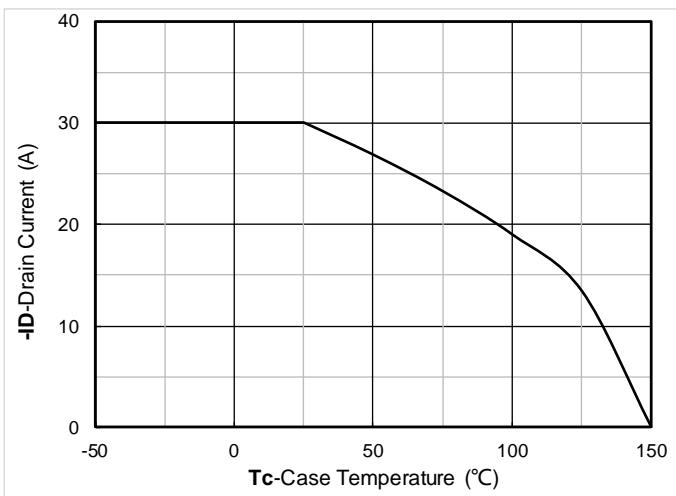


Figure 11. Current dissipation

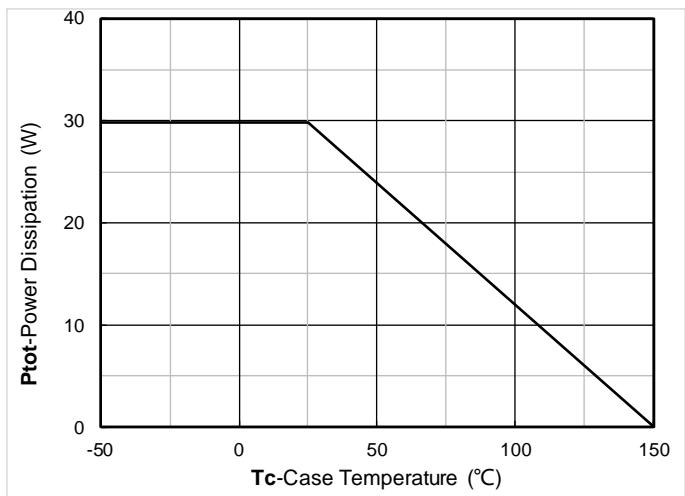


Figure 12. Power dissipation

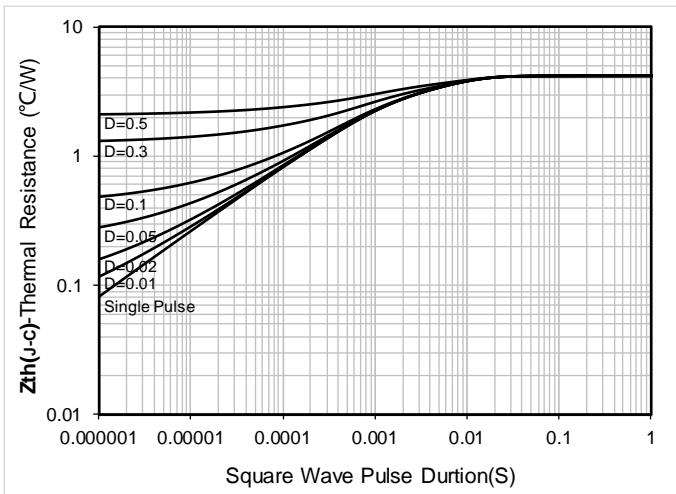


Figure 13. Maximum Transient Thermal Impedance

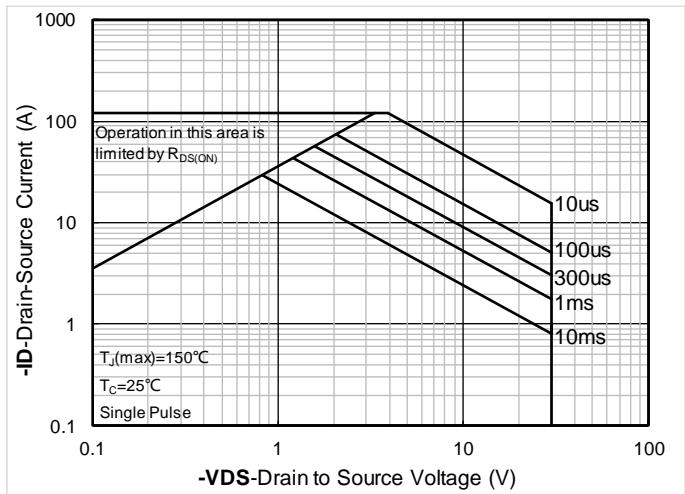
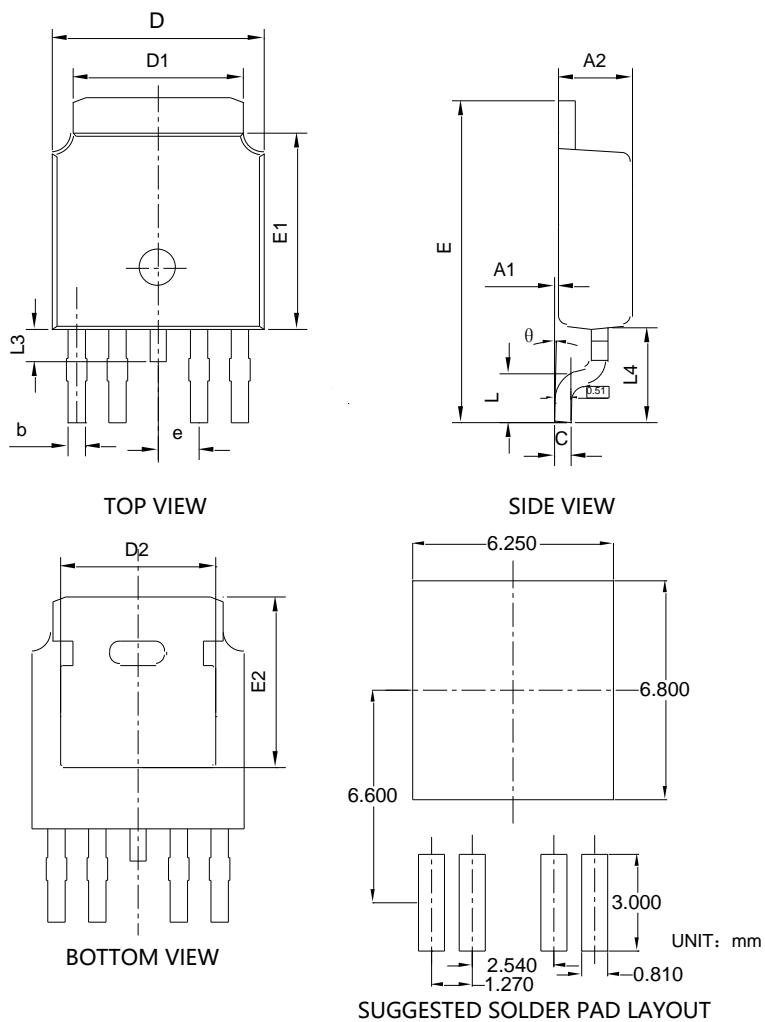


Figure 14. Safe Operation Area



■ TO-252-4L Package information



SYMBOL	DIMENSIONS			
	INCHES	Millimeter	MIN.	MAX.
A1	0.000	0.008	0.000	0.200
A2	0.085	0.094	2.150	2.400
b	0.016	0.030	0.400	0.750
c	0.018	0.026	0.450	0.650
D	0.248	0.268	6.300	6.800
D1	0.189	0.217	4.800	5.500
D2	0.150	-	3.800	-
E	0.366	0.413	9.300	10.500
E1	0.213	0.248	5.400	6.300
E2	0.177	-	4.500	-
e	0.050BSC	1.270BSC		
L	0.049	0.073	1.250	1.850
L3	-	0.047	-	1.200
L4	0.108REF	2.740REF		
?	0°	10°	0°	10°

NOTE:

- 1.PACKAGE BODY SIZES EXCLUDE MOLD FLASH AND GATE BURRS.
- 2.TOLERANCE 0.1mm UNLESS OTHERWISE SPECIFIED.
- 3.THE PAD LAYOUT IS FOR REFERENCE PURPOSES ONLY.



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